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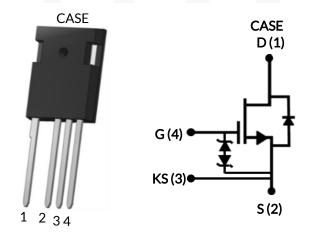


Silicon Carbide (SiC) Cascode JFET -EliteSiC, Power N-Channel, TO-247-4L, 750V, 11 mohm

Rev. C, January 2025

DATASHEET

UJ4SC075011K4S



Part Number	Package	Marking
UJ4SC075011K4S	TO-247-4L	UJ4SC075011K4S



Description

The UJ4SC075011K4S is a 750V, $11m\Omega$ G4 SiC FET. It is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads and any application requiring standard gate drive.

Features

- On-resistance R_{DS(on)}: 11mΩ (typ)
- Operating temperature: 175°C (max)
- Excellent reverse recovery: Q_{rr} = 288nC
- Low body diode V_{FSD}: 1.1V
- Low gate charge: $Q_G = 75nC$
- Threshold voltage V_{G(th)}: 4.5V (typ) allowing 0 to 15V drive
- Low intrinsic capacitance
- ESD protected, HBM class 2
- TO-247-4L package for faster switching, clean gate waveforms

Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating





Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V _{DS}		750	V
Cata source veltage	V _{GS}	DC	-20 to +20	V
Gate-source voltage	V GS	AC (f > 1Hz)	-25 to +25	V
Continuous drain current ¹	I	T _C = 25°C	104	А
Continuous drain current	ι _D	T _C = 100°C	75	А
Pulsed drain current ²	I _{DM}	T _C = 25°C	300	А
Single pulsed avalanche energy ³	E _{AS}	L=15mH, I _{AS} = 4.5A	151	mJ
SiC FET dv/dt ruggedness	dv/dt	$V_{DS} \le 500V$	100	V/ns
Power dissipation	P _{tot}	T _C = 25°C	357	W
Maximum junction temperature	T _{J,max}		175	°C
Operating and storage temperature	T _J , T _{STG}		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	TL		250	°C

1. Limited by $T_{J,max}$

2. Pulse width t_p limited by $T_{J,max}$

3. Starting $T_J = 25^{\circ}C$

4. Short circuit current is independent of the gate voltage $V_{\text{GS}}{>}12V$

Thermal Characteristics

Parameter	Symbol	Test Conditions		Units		
			Min	Тур	Max	Units
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.33	0.42	°C/W





Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

Parameter	Symphol	Test Conditions		1 Justice		
Parameter	Symbol		Min	Тур	Max	- Units
Drain-source breakdown voltage	BV _{DS}	V _{GS} =0V, I _D =1mA	750			V
		V _{DS} =750V, V _{GS} =0V, T _J =25°C		3.5	60	
Total drain leakage current	I _{DSS}	V _{DS} =750V, V _{GS} =0V, T _J =175°C		45		μA
Total gate leakage current	I _{GSS}	V _{DS} =0V, T _J =25°C, V _{GS} =-20V / +20V		2	±20	μΑ
Drain-source on-resistance	R _{DS(on)}	V _{GS} =12V, I _D =60A, T _J =25°C		11	14.2	
		V _{GS} =12V, I _D =60A, T _J =125°C		18.4		mΩ
		V _{GS} =12V, I _D =60A, T _J =175°C		24.2		
Gate threshold voltage	V _{G(th)}	V_{DS} =5V, I_{D} =10mA	3.5	4.5	5.5	V
Gate resistance	R _G	f=1MHz, open drain		2.3		Ω

Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions		Units		
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units
Diode continuous forward current ¹	ls	T _C =25°C			104	А
Diode pulse current ²	I _{S,pulse}	T _C =25°C			300	А
Forward voltage	V _{FSD}	V _{GS} =0V, I _F =30A, T _J =25°C		1.1 1.24		V
i or ward voltage		V _{GS} =0V, I _F =30A, T _J =175°C		1.2		•
Reverse recovery charge	Q _{rr}	V_{R} =400V, I _F =60A, V_{GS} =0V, R _{G_EXT} =5Ω		288		nC
Reverse recovery time	t _{rr}	di/dt=2500A/µs, T_=25°C		26		ns
Reverse recovery charge	Q _{rr}	V_{R} =400V, I _F =60A, V_{GS} =0V, R _{G_EXT} =5Ω		292		nC
Reverse recovery time	t _{rr}	di/dt=2500A/µs, Tj=150°C		26		ns





Typical Performance - Dynamic

Deveryorter	Sumahal	Test Conditions		Value		Linite	
Parameter	Symbol	Test Conditions	Min	Тур	Max	Units	
Input capacitance	C _{iss}	- V _{DS} =400V, V _{GS} =0V -		3245			
Output capacitance	C _{oss}	$v_{DS} = 400 \text{ v}, v_{GS} = 0 \text{ v}$ = f=100kHz		178		pF	
Reverse transfer capacitance	C _{rss}	1-100012		1.2			
Effective output capacitance, energy related	C _{oss(er)}	$V_{DS}=0V$ to 400V, $V_{GS}=0V$		225		pF	
Effective output capacitance, time related	C _{oss(tr)}	$V_{DS}=0V$ to 400V, $V_{GS}=0V$		470		pF	
C _{OSS} stored energy	E _{oss}	V_{DS} =400V, V_{GS} =0V		18		μJ	
Total gate charge	Q _G	– V _{DS} =400V, I _D =60A, –		75			
Gate-drain charge	Q_{GD}	$V_{DS} = -0V \text{ to } 15V$		13		nC	
Gate-source charge	Q_{GS}	VGS 0V1015V		22			
Turn-on delay time	t _{d(on)}			19			
Rise time	t _r	$\begin{tabular}{ c c c c } \hline Notes 5 and 6, & & & & & & \\ \hline V_{DS} = 400V, I_D = 60A, Gate & & & & \\ \hline Driver = 0V to + 15V, & & & & \\ \hline Turn - on R_{G,EXT} = 1\Omega, & & & & \\ \hline Turn - off R_{G,EXT} = 5\Omega, & & & & \\ \hline inductive Load, FWD: & & & \\ \hline same device with V_{GS} = 0V & & & \\ \hline \end{tabular}$		26		nc	
Turn-off delay time	t _{d(off)}			65		ns	
Fall time	t _f			9			
Turn-on energy including R_s energy	E _{ON}			257			
Turn-off energy including R_S energy	E _{OFF}			107			
Total switching energy	E _{TOTAL}	and $R_G = 5\Omega$, RC snubber: $R_S = 10\Omega$ and $C_S = 400 pF$,		364		μJ	
Snubber R_s energy during turn-on	E _{RS_ON}	$T_1=25^{\circ}C$		8			
Snubber R_S energy during turn-off	E_{RS_OFF}			21			
Turn-on delay time	t _{d(on)}			19			
Rise time	t _r	Notes 5 and 6, V _{DS} =400V, I _D =60A, Gate		28		nc	
Turn-off delay time	t _{d(off)}	Driver = $0V$ to +15V,		73		ns	
Fall time	t _f	Turn-on $R_{G,EXT}=1\Omega$, Turn-off $R_{G,EXT}=5\Omega$, inductive Load, FWD: same device with $V_{GS} = 0V$ and		9			
Turn-on energy including R_s energy	E _{ON}			320			
Turn-off energy including R_s energy	E _{OFF}			125			
Total switching energy	E _{TOTAL}	$R_{\rm G} = 5\Omega$, RC snubber:		445		μJ	
Snubber R_s energy during turn-on	E _{RS_ON}	$- R_{s}=10\Omega \text{ and } C_{s}=400\text{pF}, - T_{J}=150^{\circ}\text{C}$		8			
Snubber R_s energy during turn-off	E _{RS_OFF}			19		1	

5. Measured with the switching test circuit in Figure 29.

6. In this datasheet, all the switching energies (turn-on energy, turn-off energy and total energy) presented in the tables and Figures include the device RC snubber energy losses.





Typical Performance Diagrams

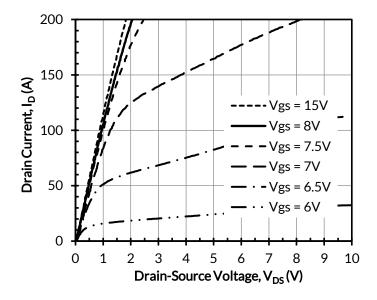


Figure 1. Typical output characteristics at $T_{\rm J}$ = - 55°C, tp < 250 μs

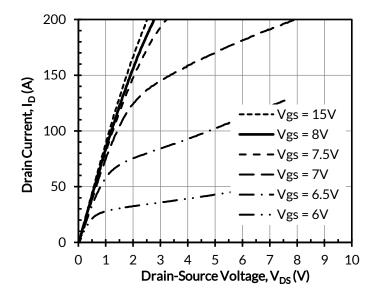


Figure 2. Typical output characteristics at T $_{\rm J}$ = 25°C, tp < 250 μs

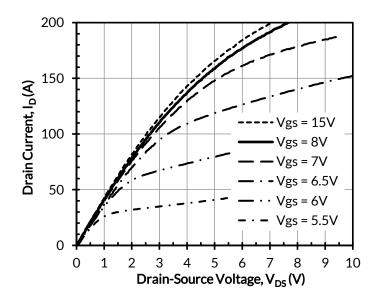


Figure 3. Typical output characteristics at T $_{\rm J}$ = 175°C, tp < 250 μs

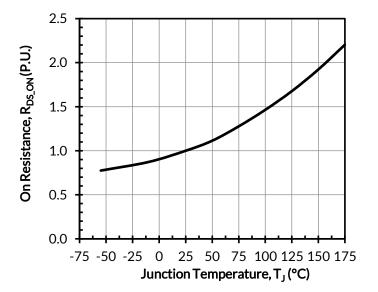
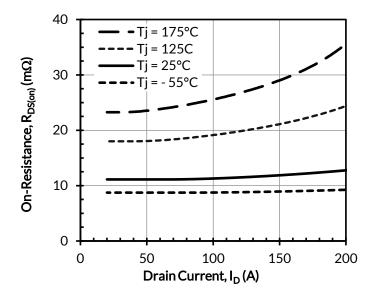
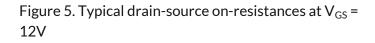


Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V and I_{D} = 60A



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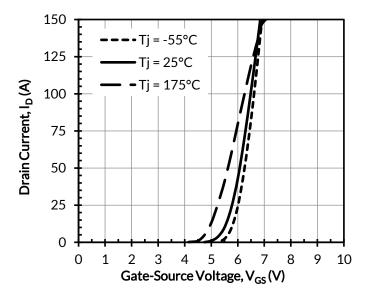


Figure 6. Typical transfer characteristics at V_{DS} = 5V

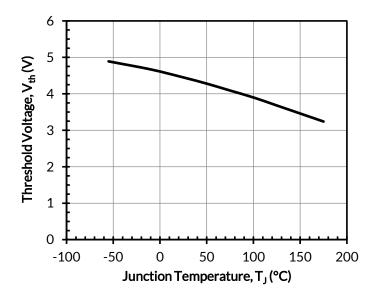


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_{D} = 10mA

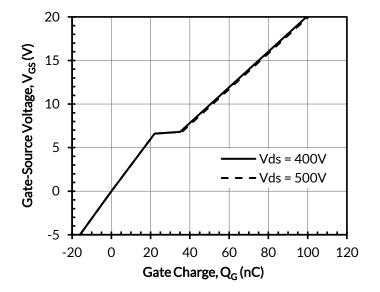


Figure 8. Typical gate charge at I_D = 60A

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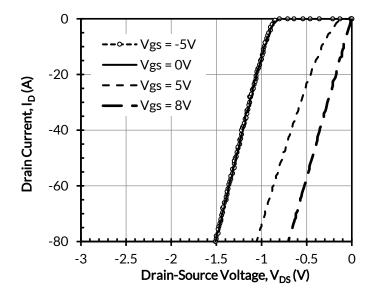


Figure 9. 3rd quadrant characteristics at $T_J = -55^{\circ}C$

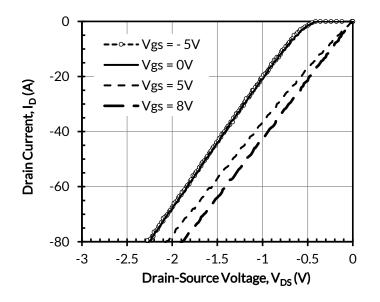


Figure 11. 3rd quadrant characteristics at T_J = 175°C

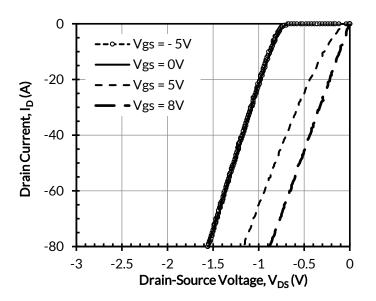


Figure 10. 3rd quadrant characteristics at $T_J = 25^{\circ}C$

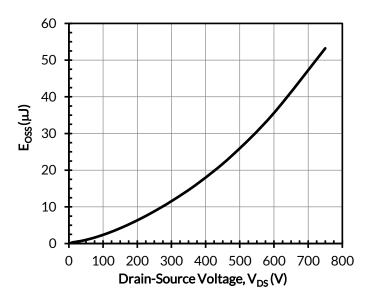


Figure 12. Typical stored energy in C_{OSS} at V_{GS} = 0V





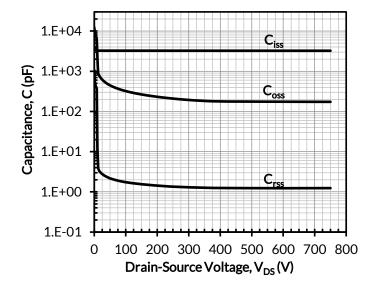


Figure 13. Typical capacitances at f = 100kHz and V_{GS} = 0V

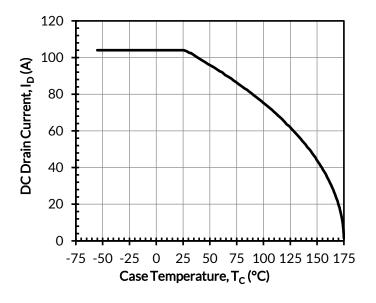


Figure 14. DC drain current derating

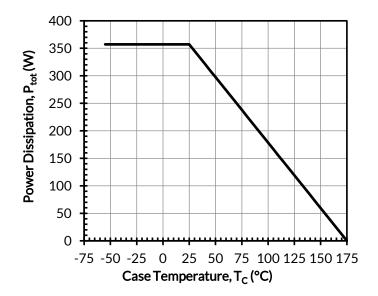


Figure 15. Total power dissipation

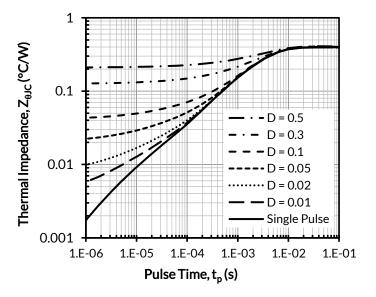


Figure 16. Maximum transient thermal impedance



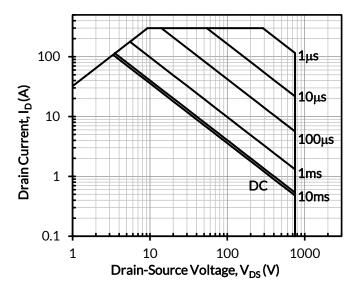


Figure 17. Safe operation area at T_C = 25°C, D = 0, Parameter t_p

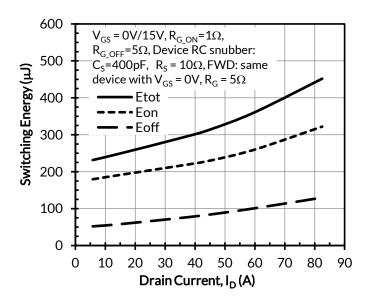
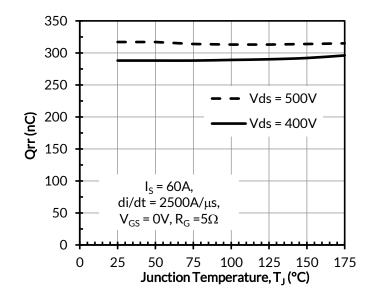


Figure 19. Clamped inductive switching energy vs. drain current at V_{DS} = 400V and T_J = 25°C



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Figure 18. Reverse recovery charge Qrr vs. junction temperature

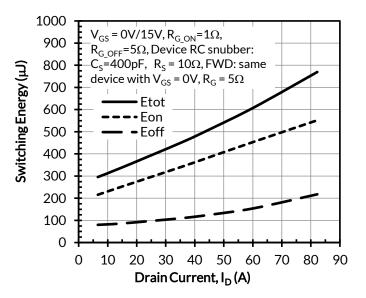


Figure 20. Clamped inductive switching energy vs. drain current at V_{DS} = 500V and T_J = 25°C





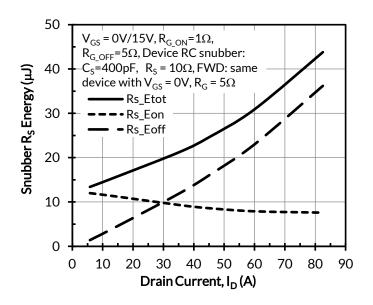


Figure 21. RC snubber energy loss vs. drain current at V_{DS} = 400V and T_J = 25°C

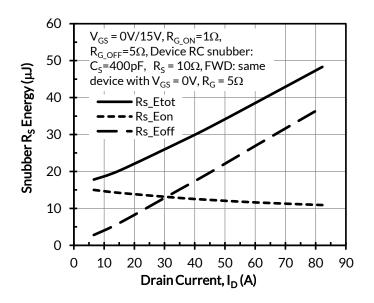


Figure 22. RC snubber energy losses vs. drain current at V_{DS} = 500V and T_J = 25°C

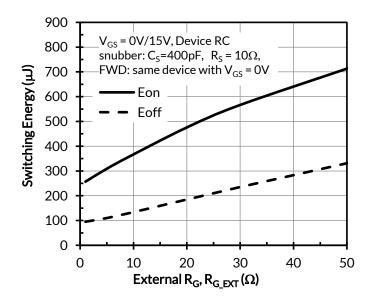


Figure 23. Clamped inductive switching energies vs. $R_{G,EXT}$ at V_{DS} = 400V, I_D = 60A, and T_J = 25°C

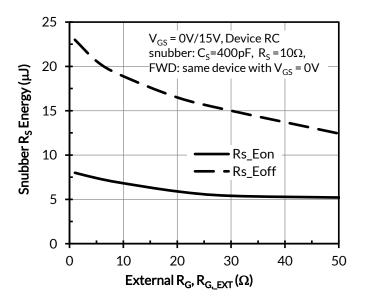
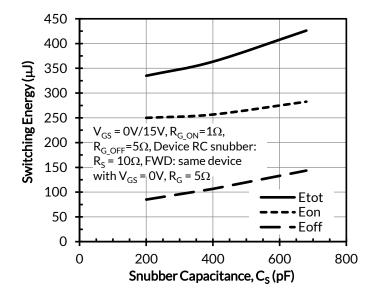
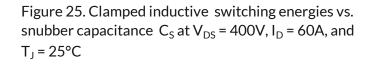


Figure 24. RC snubber energy losses vs. $R_{G,EXT}$ at V_{DS} = 400V, I_D = 60A, and T_1 = 25°C







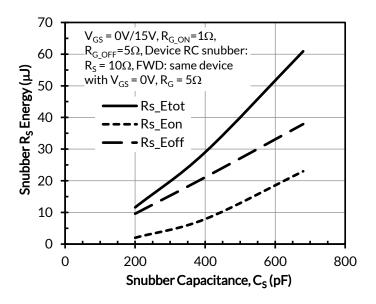


Figure 26. RC snubber energy losses vs. snubber capacitance C_s at V_{DS} = 400V, I_D = 60A, and T_J = 25°C

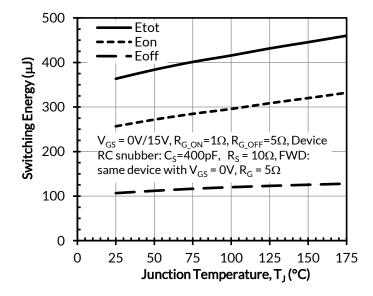


Figure 27. Clamped inductive switching energy vs. junction temperature at V_{DS} =400V and I_D = 60A

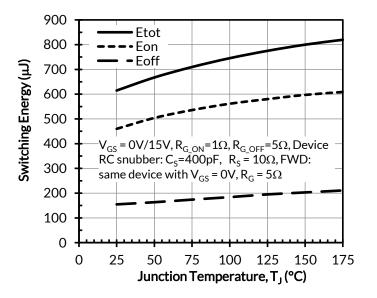


Figure 28. Clamped inductive switching energy vs. junction temperature at V_{DS} =500V and I_D = 60A





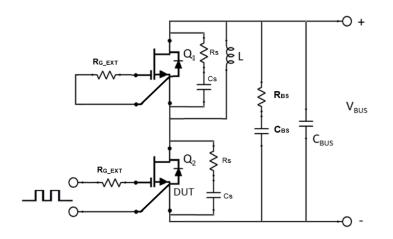


Figure 29. Schematic of the half-bridge mode switching test circuit. Note, a bus RC snubber ($R_{BS} = 1\Omega$, $C_{BS} = 100$ nF) is used to reduce the power loop high frequency oscillations.

Applications Information

SiC FETs are enhancement-mode power switches formed by a highvoltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Qrr) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

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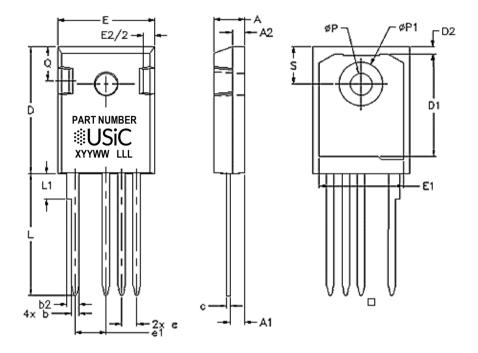
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TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

PACKAGE OUTLINE



DIM	INC	HES	MILLIMETERS		
	MIN	MAX	MIN	MAX	
A	0.185	0.209	4.7	5.31	
A1	0.087	0.102	2.21	2.59	
A2	0.059	0.098	1.5	2.49	
b	0.039	0.055	0.99	1.4	
b2	0.065	0.094	1.65	2.39	
С	0.015	0.035	0.38	0.89	
D	0.819	0.845	20.8	21.46	
D1	0.515	-	13.08	-	
D2	0.02	0.053	0.51	1.35	
E	0.61	0.64	15.49	16.26	
е	0.100 BSC		2.54 BSC		
e1	0.19	0.21	4.83	5.33	
E1	0.53	-	13.46	-	
E2	0.14	0.16	3.56	4.06	
L	0.78	0.8	19.81	20.32	
L1	-	0.177	-	4.5	
ФР	0.14	0.144	3.56	3.66	
ΦΡ1	0.278	0.291	7.06	7.39	
Q	0.212	0.244	5.38	6.2	
S	0.243 BSC		6.17 BSC		



TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

PART NUMBER = REFER TO DS_PN DECODER FOR DETAILS X = ASSEMBLY SITE

YY = YEAR WW = WORK WEEK LLL = LOT ID

PACKING TYPE

ANTI-STATIC TUBE

QUANTITY /TUBE : 30 UNITS

XYYWW

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